Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/635,410	VAN EGMOND ET AL.
Examiner	Art Unit
Tam M. Nguyen	1764

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SEARCHED					
Class	Subclass	Date	Examiner		
585	809 638 820 639	_. 5/26/2005	TN		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST	5/26/2006	TN	
INVENTORS SEARCHED	5/26/2006	TN	
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